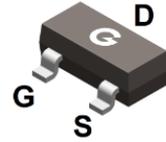
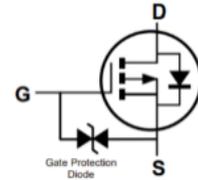


Features

- Extremely low threshold voltage
- ESD protected
- Advanced trench cell design

HF



SOT-23

Mechanical Data

- Case: SOT-23
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208

Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
BL1015	SOT-23	3000 pcs / Tape & Reel	1015

Maximum Ratings (@ T_A = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	-30	V
Gate-to-Source Voltage	V _{GSS}	±10	V
Continuous Drain Current	I _D	-0.33	A
Pulsed Drain Current	I _{DM}	-1.32	A
Power Dissipation(T _A = 25°C)	P _D	0.42	W
Operating Junction Temperature Range	T _J	-55 ~ +150	°C
Storage Temperature Range	T _{STG}	-55 ~ +150	°C

Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Air *1	R _{θJA}	-	-	300	°C/W

Electrical Characteristics (@ T_A = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
V _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = -250μA	-30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -30V, V _{GS} = 0V	-	-	-1	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±8V, V _{DS} = 0V	-	-	±10	μA
On Characteristics						
R _{DS(ON)}	Drain-Source On-resistance *2	V _{GS} = -4.5V, I _D = -0.3A	-	-	2.5	Ω
		V _{GS} = -2.5V, I _D = -0.2A	-	-	2.9	Ω
		V _{GS} = -1.8V, I _D = -0.1A	-	-	5	Ω
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250μA	-0.4	-	-1.0	V
Dynamic Characteristics						
C _{ISS}	Input Capacitance	V _{GS} = 0V	-	50	-	pF
C _{OSS}	Output Capacitance	V _{DS} = -10V	-	6	-	
C _{RSS}	Reverse Transfer Capacitance	f = 1.0MHz	-	5	-	
Switching Characteristics						
t _{d(ON)}	Turn-on Delay Time *3	V _{DD} = -10V, V _{GS} = -4.5V R _G = 6Ω, R _L = 150Ω I _D = -0.1A	-	3.4	-	ns
t _r	Turn-on Rise Time *3		-	13	-	
t _{d(OFF)}	Turn-Off Delay Time *3		-	37	-	
t _f	Turn-Off Fall Time *3		-	23	-	
Q _G	Total Gate-Charge	V _{DD} = -10V	-	1.22	-	nC
Q _{GS}	Gate to Source Charge	V _{GS} = -4.5V	-	0.33	-	
Q _{GD}	Gate to Drain (Miller) Charge	I _D = -0.1A	-	0.22	-	
Source-Drain Diode Characteristics						
V _{SD}	Diode Forward Voltage *2	I _{SD} = -0.3 A, V _{GS} = 0V	-	-	-1.3	V

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper
2. The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%
3. Guaranteed by design, not subject to production

Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

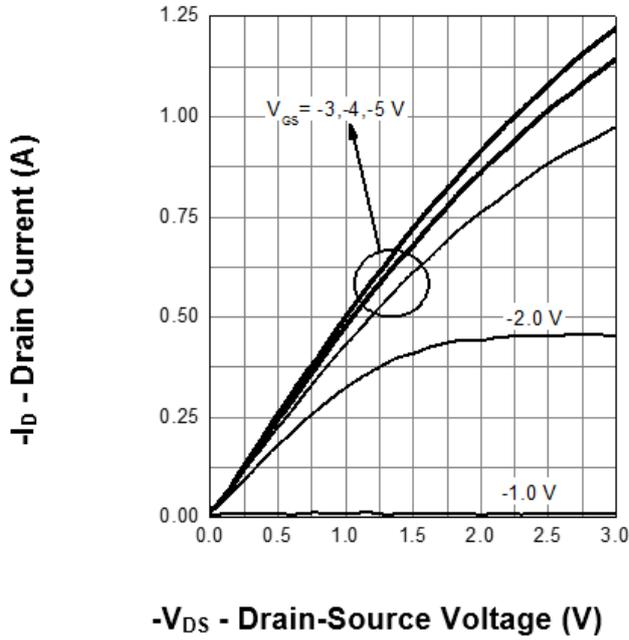


Fig. 1 Typical Output Characteristics

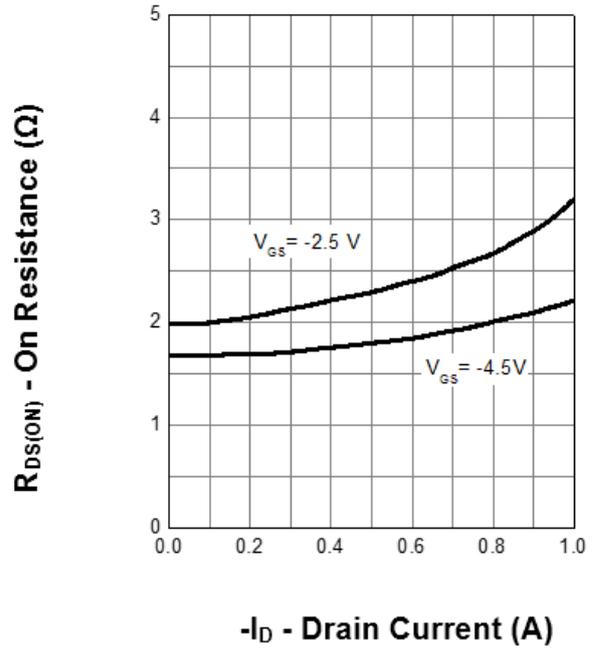


Fig. 2 On-Resistance vs. Drain Current and Gate Voltage

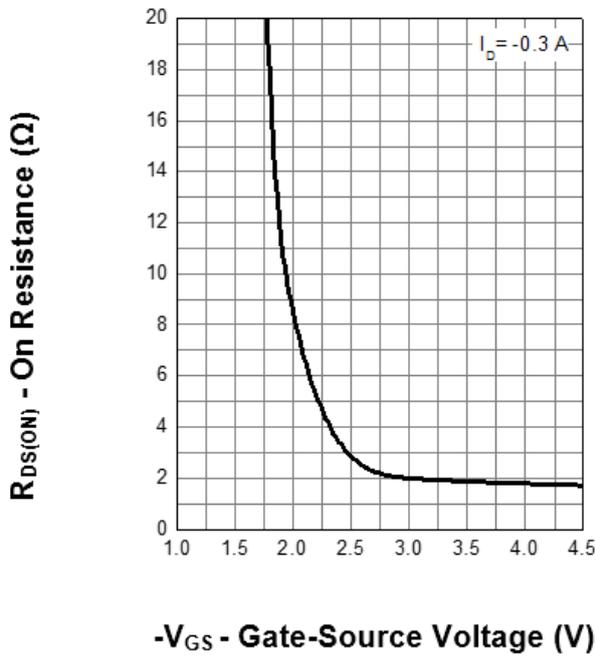


Fig. 3 On-Resistance vs. Gate-Source Voltage

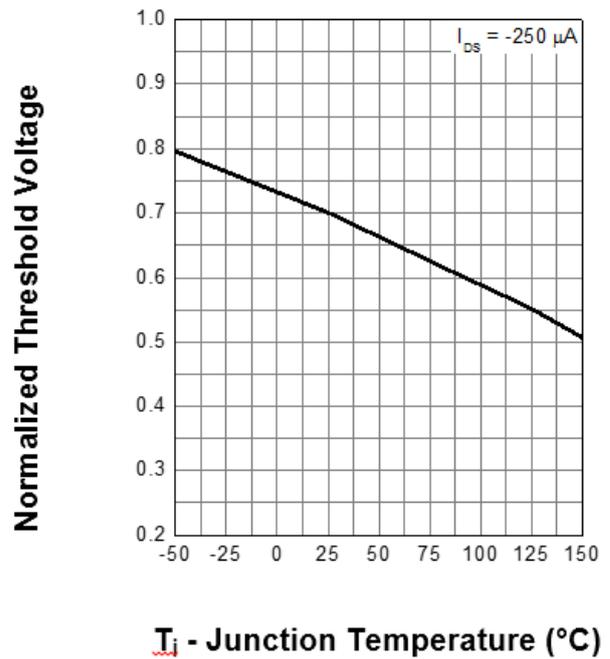


Fig. 4 Normalized $V_{GS(th)}$ vs. Junction Temperature

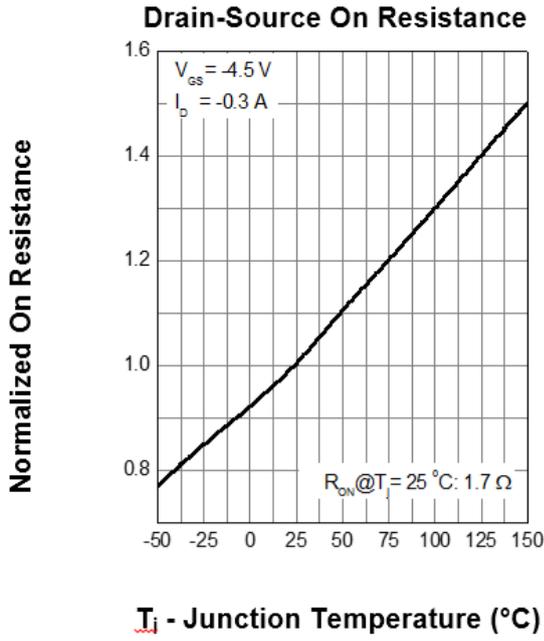


Fig. 5 Normalized On-Resistance vs. Junction Temperature

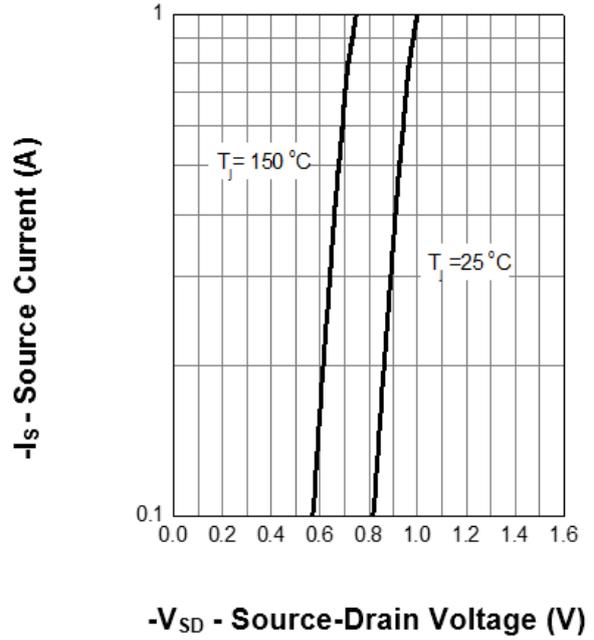


Fig. 6 Body-Diode Characteristics

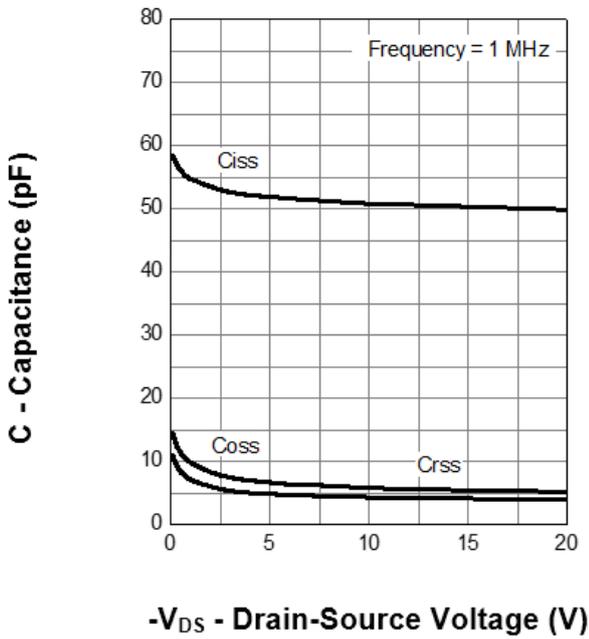


Fig. 7 Capacitance Characteristics

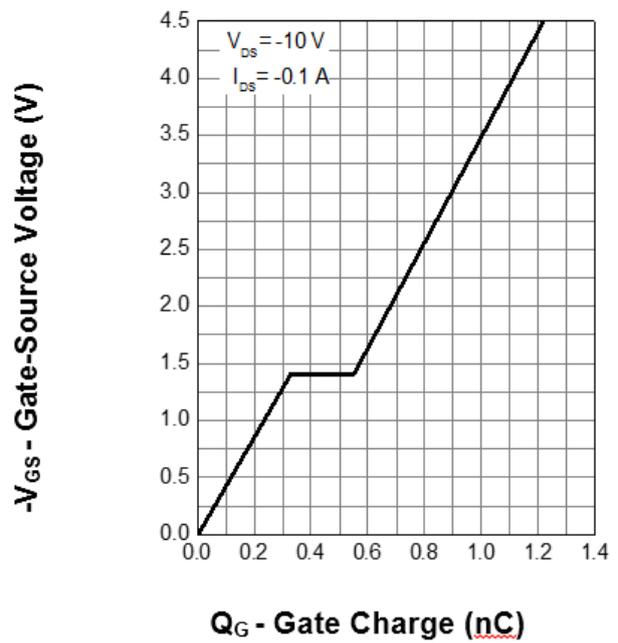
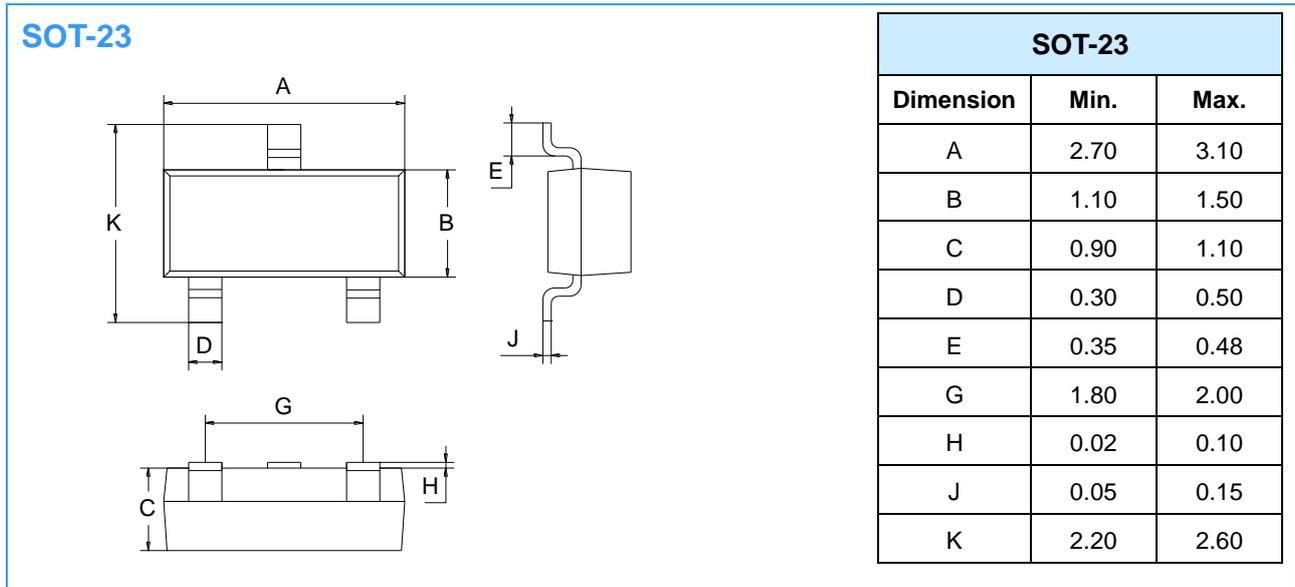
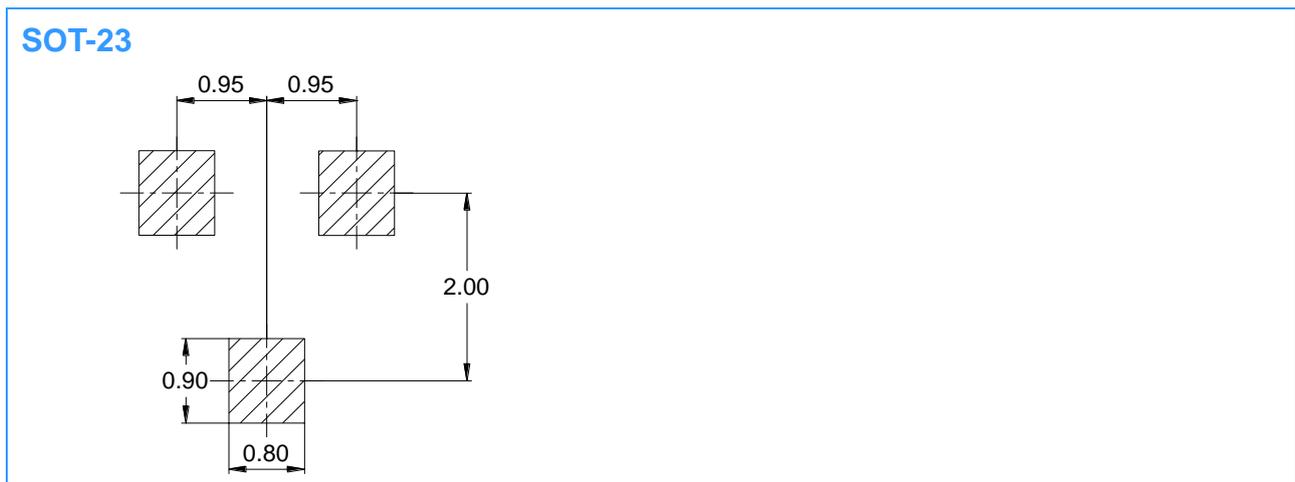


Fig. 8 Gate-Charge Characteristics

Package Outline Dimensions (Unit: mm)



Mounting Pad Layout (Unit: mm)



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